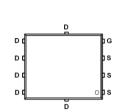
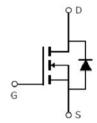


### **Main Product Characteristics:**

V <sub>DSS</sub>	100V			
R <sub>DS</sub> (on)	4.2mΩ (typ.)			
I <sub>D</sub>	140A			







PDFN5x6-8L

Pin Assignments

Schematic Diagram

### **Features and Benefits:**

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



## **Description:**

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

## **Absolute Max Rating:**

Symbol	Parameter	Max.	Units
In @ Tc = 25°C	Continuous Drain Current, Ves @ 10V ①	140	
In @ Tc = 100°C	Continuous Drain Current, Vos @ 10V ①	85	Α
Ірм	Pulsed Drain Current ②	417	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation ③	266	W
Vos	Drain-Source Voltage	100	V
Vgs	Gate-to-Source Voltage	± 20	V
Eas	Single Pulse Avalanche Energy @ L=0.5mH	380	mJ
las	Avalanche Current	39	Α
TJ TSTG	Operating Junction and Storage Temperature Range	-55 to +150	°C



## **Thermal Resistance**

Symbol	Characterizes	Тур.	Max.	Units
Rejc	Junction-to-case ③	1	0.47	°C/W

## Electrical Characterizes @TA=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V(BR)DSS	Drain-to-Source breakdown voltage	100	_	_	V	Vgs = 0V, ID = 250µA
RDS(on)	Static Drain-to-Source on-resistance	_	4.2	6	mΩ	Vgs=10V,ID = 20A
V <sub>GS(th)</sub>	Gate threshold voltage	2	_	4	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250µA
Ipss	Drain-to-Source leakage current	_	_	1	μA	V <sub>DS</sub> = 100V,V <sub>GS</sub> = 0V
lana		_	_	100		V <sub>GS</sub> =20V
lgss	Gate-to-Source forward leakage	_	_	-100	nA	V <sub>GS</sub> = -20V
Ciss	Input capacitance		3820	_		V <sub>GS</sub> = 0V
Coss	Output capacitance	_	589	_	pF	V <sub>DS</sub> = 50V
Crss	Reverse transfer capacitance	_	18	_		f = 100kHz
Qg	Total gate charge	_	42	_		I <sub>D</sub> = 20A,
Qgs	Gate-to-Source charge	_	12	_	nC V <sub>DS</sub> =50V,	V <sub>DS</sub> =50V,
Qgd	Gate-to-Drain("Miller") charge	_	10	_		Vgs = 10V
td(on)	Turn-on delay time	_	29.4	_		
tr	Rise time		44	_		V <sub>GS</sub> =10V, V <sub>DS</sub> =50V,
td(off)	Turn-Off delay time	_	47	_	ns	R <sub>GEN</sub> =3.6Ω, R <sub>L</sub> =2.2Ω
tf	Fall time	_	12	_		

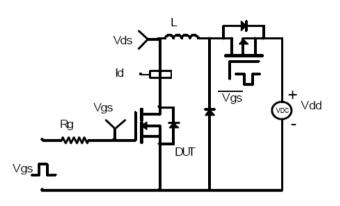
# **Source-Drain Ratings and Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current		_	167	А	MOSFET symbol
	(Body Diode)					showing the
Іѕм	Pulsed Source Current	_	_	417	Α	integral reverse
	(Body Diode)					p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage	_	_	1.2	V	Is=20A, Vgs=0V
trr	Reverse Recovery Time	_	61	_	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = 20A, di/dt =
Qrr	Reverse Recovery Charge	_	62	_	nC	100A/μs

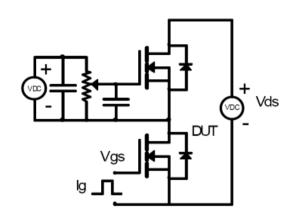


## **Test Circuits and Waveforms**

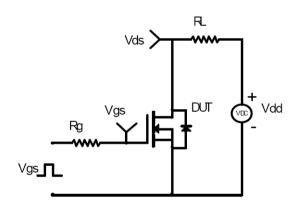
#### **EAS Test Circuit:**



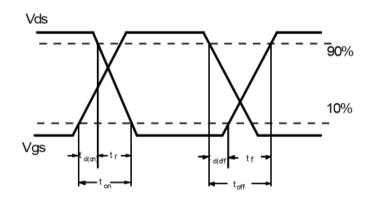
#### **Gate Charge Test Circuit:**



#### **Switching Time Test Circuit:**



#### **Switching Waveforms:**



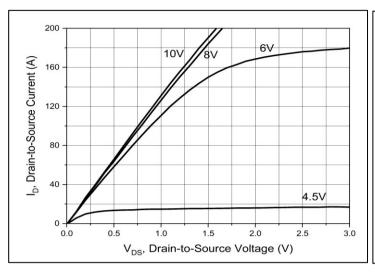
Version: 1.0

### Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- (3) The power dissipation P<sub>D</sub> is based on max. junction temperature, using junction-to-case thermal resistance.



# **Typical Electrical and Thermal Characteristics**



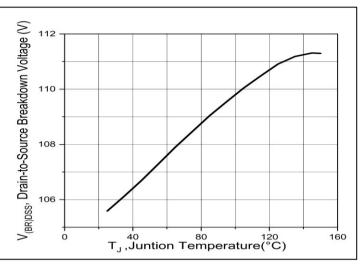
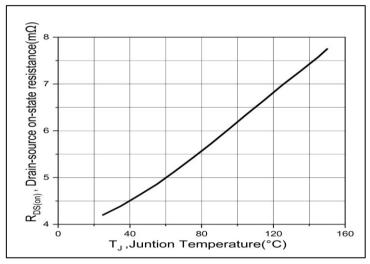


Figure 1. Typical Output Characteristics

Figure2. Drain-to-Source Breakdown Voltage vs. Junction Temperature



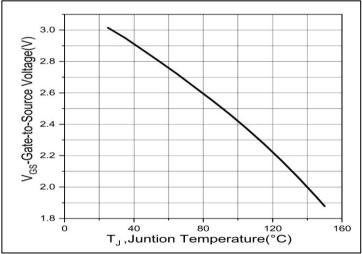
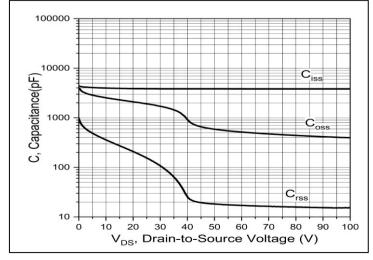


Figure 3. RDS(on) vs. Junction Temperature

Figure 4. Vth vs. Junction Temperature



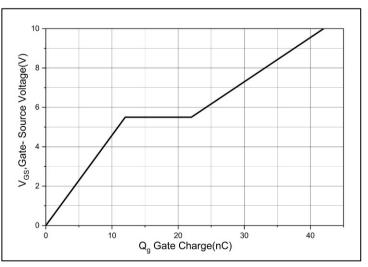


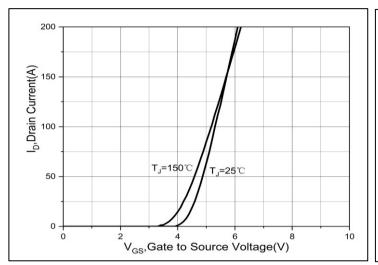
Figure5. Capacitance

Figure 6. Gate Charge





# **Typical Electrical and Thermal Characteristics**



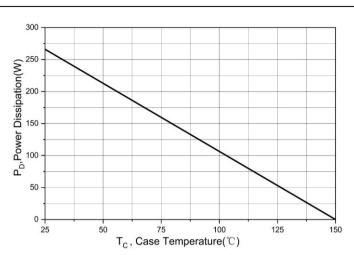
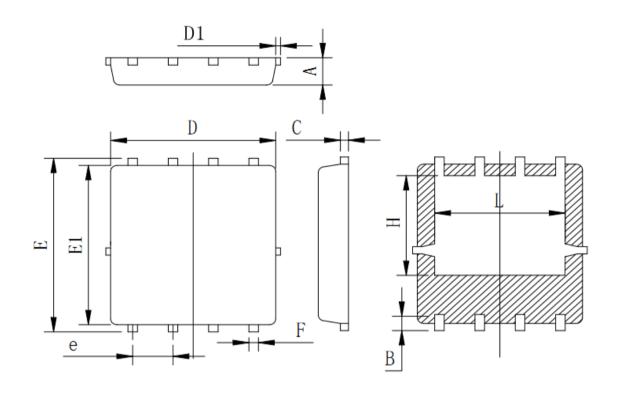


Figure 7. Transfer Characteristics

Figure8. Power Dissipation



# **Mechanical Data:**



Symbol	Min	Тур	Max
A	0.90	0.95	1.00
В	0.48	0.58	0.68
С	0.20	0.254	0.30
D	5.00	5.20	5.40
Dl			0.15
Е	5.90	6.05	6.20
El	5.40	5.55	5.70
e	1.22	1.27	1.32
F	0.25	0.30	0.35
Н	3.27	3.47	3.67
L	3.80	4.00	4.20





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